# Introduction to CMOS VLSI Design

**Lecture 04: Introduction** 

#### Introduction

- ☐ Integrated circuits: many transistors on one chip.
- Very Large Scale Integration (VLSI): very many
- ☐ Complementary Metal Oxide Semiconductor
  - Fast, cheap, low power transistors
- □ Today: How to build your own simple CMOS chip
  - CMOS transistors
  - Building logic gates from transistors
  - Transistor layout and fabrication
- □ Rest of the course: How to build a good CMOS chip

## **Silicon Lattice**

- ☐ Transistors are built on a silicon substrate
- □ Silicon is a Group IV material
- Forms crystal lattice with bonds to four neighbors

# **Dopants**

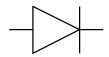
- ☐ Silicon is a semiconductor.
- Pure silicon has no free carriers and conducts poorly
- Adding dopants increases the conductivity
- □ Group V: extra electron (n-type)
- Group III: missing electron, called hole (p-type)

# p-n Junctions

- □ A junction between p-type and n-type semiconductor forms a diode.
- Current flows only in one direction

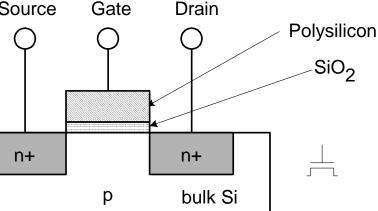
p-type in-type

anode cathode



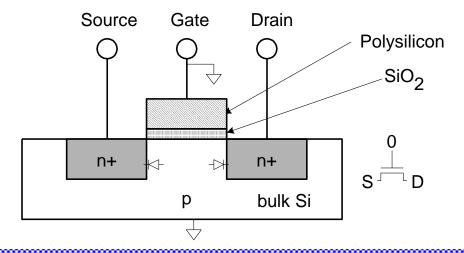
## **nMOS Transistor**

- ☐ Four terminals: gate, source, drain, body
- Gate oxide body stack looks like a capacitor
  - Gate and body are conductors
  - SiO<sub>2</sub> (oxide) is a very good insulator
  - Called metal oxide semiconductor (MOS)
    capacitor
    Source Gate Drain
  - Even though gate is no longer made of metal



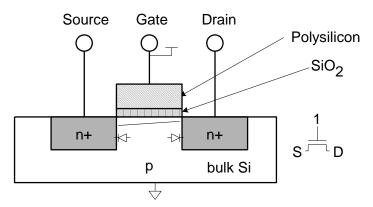
# nMOS Operation

- Body is commonly tied to ground (0 V)
- When the gate is at a low voltage:
  - P-type body is at low voltage
  - Source-body and drain-body diodes are OFF
  - No current flows, transistor is OFF



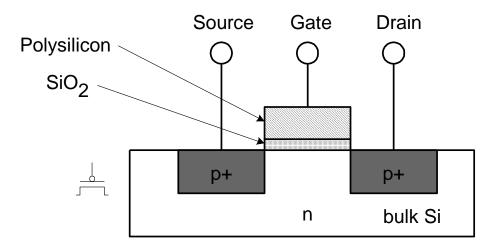
# nMOS Operation Cont.

- ☐ When the gate is at a high voltage:
  - Positive charge on gate of MOS capacitor
  - Negative charge attracted to body
  - Inverts a channel under gate to n-type
  - Now current can flow through n-type silicon from source through channel to drain, transistor is ON



# pMOS Transistor

- □ Similar, but doping and voltages reversed
  - Body tied to high voltage (V<sub>DD</sub>)
  - Gate low: transistor ON
  - Gate high: transistor OFF
  - Bubble indicates inverted behavior



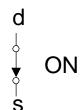
# **Power Supply Voltage**

- $\Box$  GND = 0 V
- ☐ In 1980's,  $V_{DD} = 5V$
- V<sub>DD</sub> has decreased in modern processes
  - High V<sub>DD</sub> would damage modern tiny transistors
  - Lower V<sub>DD</sub> saves power
- $\Box$   $V_{DD} = 3.3, 2.5, 1.8, 1.5, 1.2, 1.0, ...$

## **Transistors as Switches**

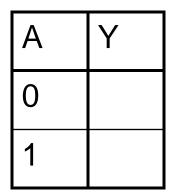
- We can view MOS transistors as electrically controlled switches
- ☐ Voltage at gate controls path from source to drain

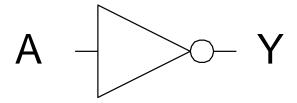
g = 0

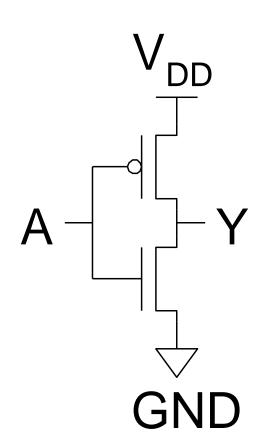


g = 1

## **CMOS Inverter**



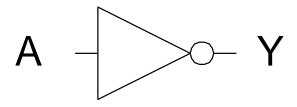


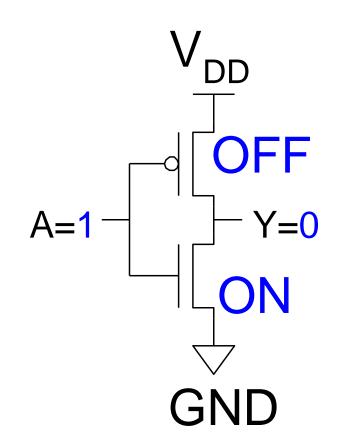


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## **CMOS Inverter**

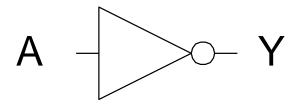
А	Υ
0	
1	0

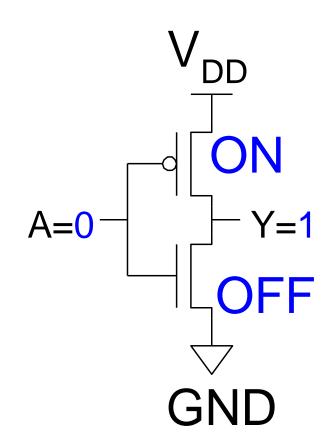




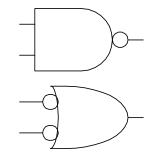
## **CMOS Inverter**

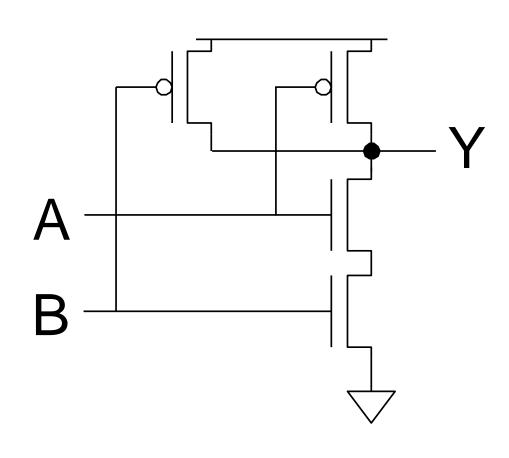
Α	Υ
0	1
1	0





Α	В	Υ
0	0	
0	1	
1	0	
1	1	

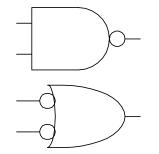


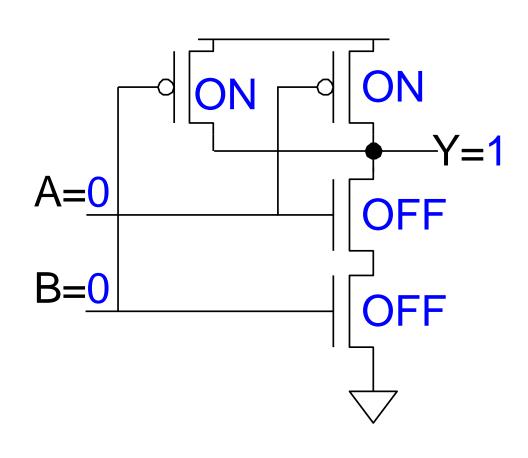


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**CMOS VLSI Design** 

Α	В	Υ
0	0	1
0	1	
1	0	
1	1	

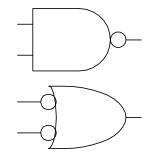


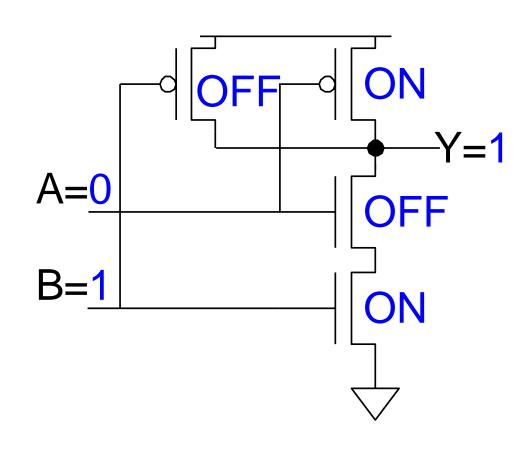


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**CMOS VLSI Design** 

Α	В	Υ
0	0	1
0	1	1
1	0	
1	1	

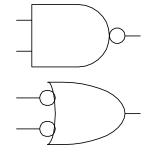


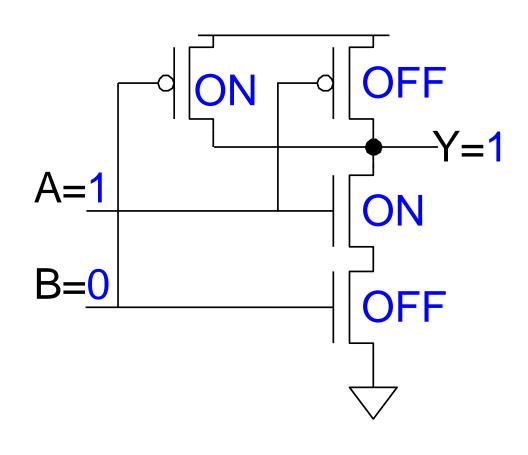


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**CMOS VLSI Design** 

Α	В	Υ
0	0	1
0	1	1
1	0	1
1	1	

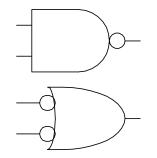


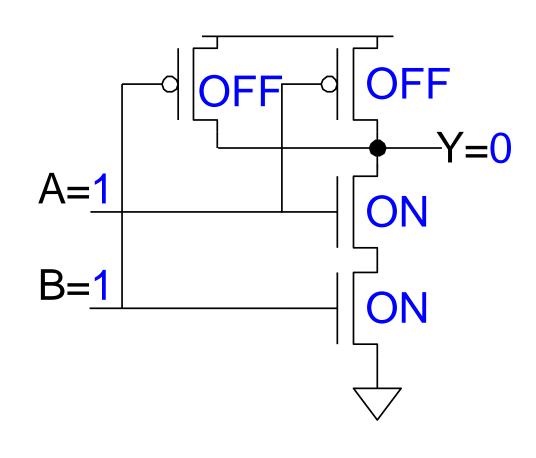


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**CMOS VLSI Design** 

Α	В	Υ
0	0	1
0	1	1
1	0	1
1	1	0



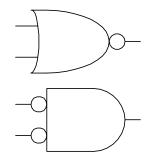


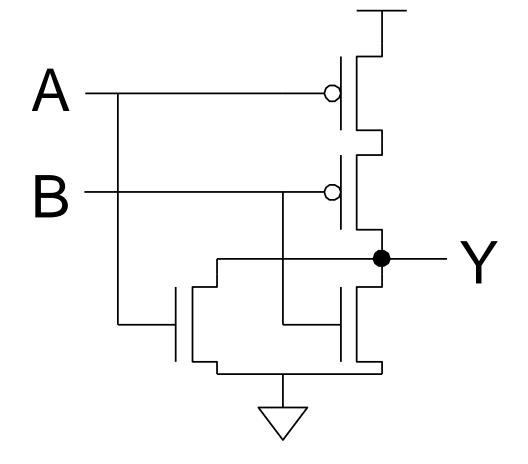
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**CMOS VLSI Design** 

## **CMOS NOR Gate**

А	В	Υ
0	0	1
0	1	0
1	0	0
1	1	0





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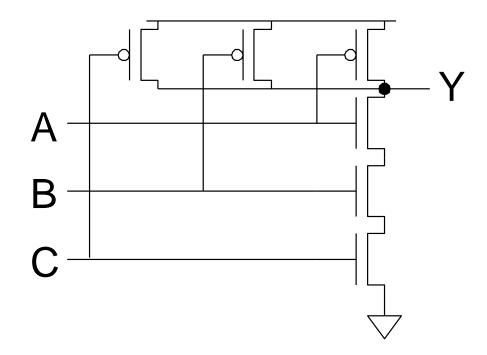
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# 3-input NAND Gate

- ☐ Y pulls low if ALL inputs are 1
- Y pulls high if ANY input is 0

# **3-input NAND Gate**

- ☐ Y pulls low if ALL inputs are 1
- ☐ Y pulls high if ANY input is 0

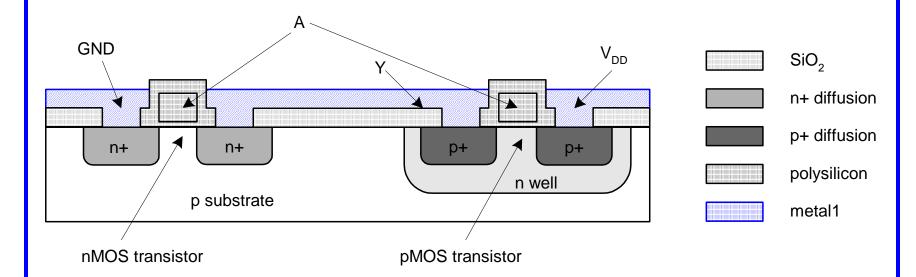


## **CMOS Fabrication**

- ☐ CMOS transistors are fabricated on silicon wafer
- ☐ Lithography process similar to printing press
- On each step, different materials are deposited or etched
- Easiest to understand by viewing both top and cross-section of wafer in a simplified manufacturing process

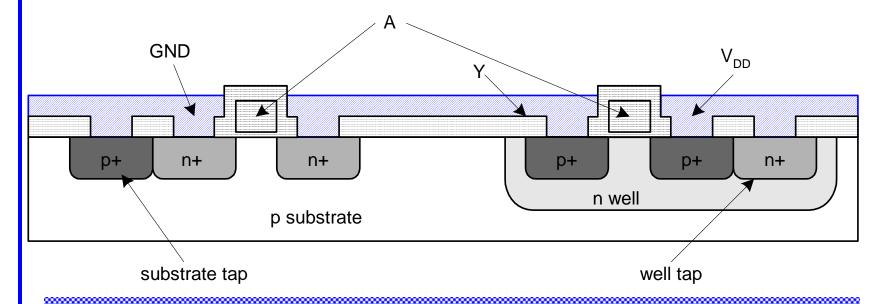
#### **Inverter Cross-section**

- ☐ Typically use p-type substrate for nMOS transistors
- □ Requires n-well for body of pMOS transistors



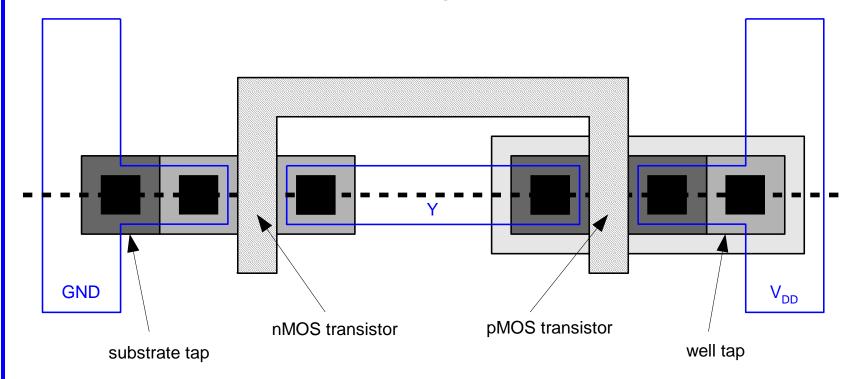
# Well and Substrate Taps

- Substrate must be tied to GND and n-well to V<sub>DD</sub>
- Metal to lightly-doped semiconductor forms poor connection called Shottky Diode
- ☐ Use heavily doped well and substrate contacts / taps



## **Inverter Mask Set**

- ☐ Transistors and wires are defined by *masks*
- Cross-section taken along dashed line

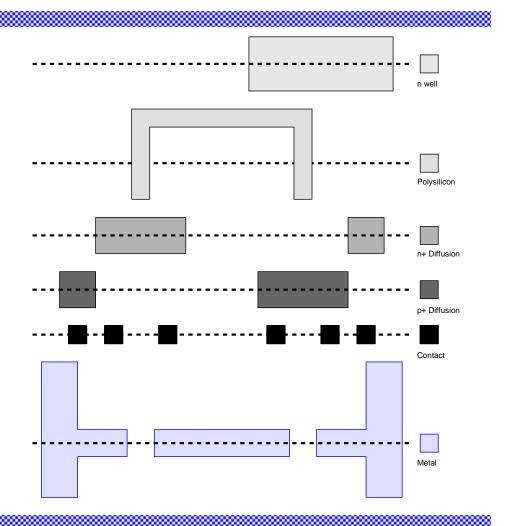


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## **Detailed Mask Views**

- Six masks
  - n-well
  - Polysilicon
  - n+ diffusion
  - p+ diffusion
  - Contact
  - Metal



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# **Fabrication Steps**

- ☐ Start with blank wafer
- Build inverter from the bottom up
- First step will be to form the n-well
  - Cover wafer with protective layer of SiO<sub>2</sub> (oxide)
  - Remove layer where n-well should be built
  - Implant or diffuse n dopants into exposed wafer
  - Strip off SiO<sub>2</sub>

## **Oxidation**

- ☐ Grow SiO₂ on top of Si wafer
  - 900 1200 C with H<sub>2</sub>O or O<sub>2</sub> in oxidation furnace

SiO<sub>2</sub>

#### **Photoresist**

- ☐ Spin on photoresist
  - Photoresist is a light-sensitive organic polymer
  - Softens where exposed to light

**Photoresist** 

SiO<sub>2</sub>

# Lithography

- ☐ Expose photoresist through n-well mask
- □ Strip off exposed photoresist



Photoresist SiO<sub>2</sub>

#### **Etch**

- ☐ Etch oxide with hydrofluoric acid (HF)
  - Seeps through skin and eats bone; nasty stuff!!!
- Only attacks oxide where resist has been exposed

Photoresist SiO<sub>2</sub>

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# **Strip Photoresist**

- ☐ Strip off remaining photoresist
  - Use mixture of acids called piranah etch
- Necessary so resist doesn't melt in next step

 $\mathsf{SiO}_2$ 

· ·

#### n-well

- n-well is formed with diffusion or ion implantation
- Diffusion
  - Place wafer in furnace with arsenic gas
  - Heat until As atoms diffuse into exposed Si
- □ Ion Implanatation
  - Blast wafer with beam of As ions
  - Ions blocked by SiO<sub>2</sub>, only enter exposed Si

SiO<sub>2</sub>

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# **Strip Oxide**

- ☐ Strip off the remaining oxide using HF
- Back to bare wafer with n-well
- ☐ Subsequent steps involve similar series of steps

n well p substrate

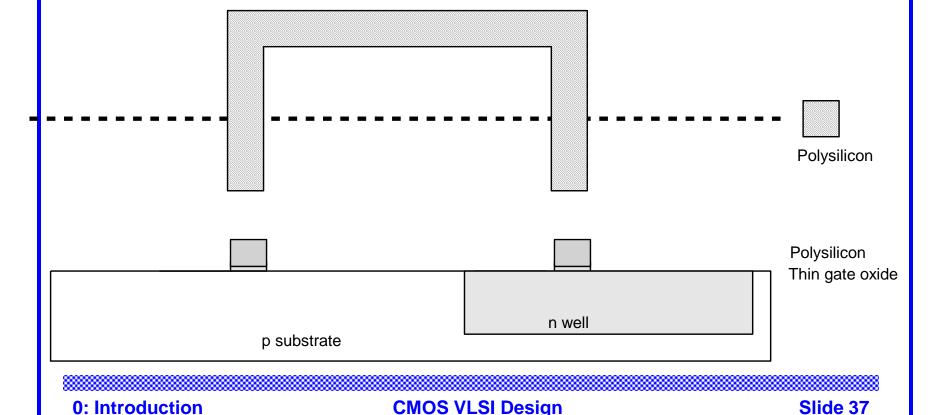
# Polysilicon

- Deposit very thin layer of gate oxide
  - < 20 Å (6-7 atomic layers)</p>
- □ Chemical Vapor Deposition (CVD) of silicon layer
  - Place wafer in furnace with Silane gas (SiH<sub>4</sub>)
  - Forms many small crystals called polysilicon
  - Heavily doped to be good conductor

Polysilicon Thin gate oxide p substrate

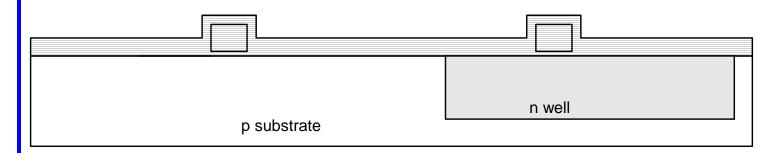
## **Polysilicon Patterning**

☐ Use same lithography process to pattern polysilicon



## **Self-Aligned Process**

- ☐ Use oxide and masking to expose where n+ dopants should be diffused or implanted
- N-diffusion forms nMOS source, drain, and n-well contact

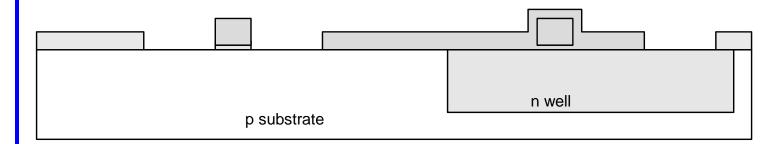


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#### **N-diffusion**

- □ Pattern oxide and form n+ regions
- ☐ Self-aligned process where gate blocks diffusion
- Polysilicon is better than metal for self-aligned gates because it doesn't melt during later processing



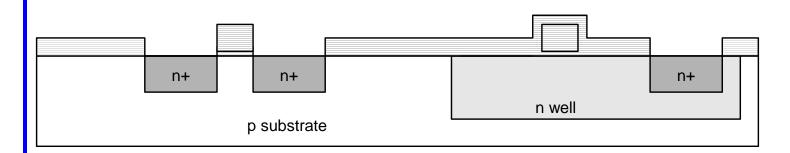


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#### N-diffusion cont.

- Historically dopants were diffused
- Usually ion implantation today
- □ But regions are still called diffusion

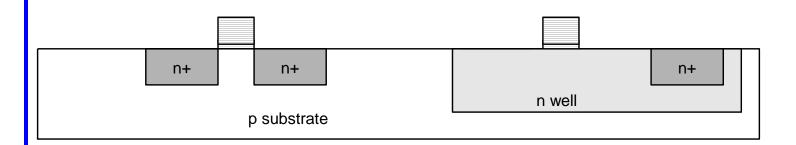


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### N-diffusion cont.

☐ Strip off oxide to complete patterning step

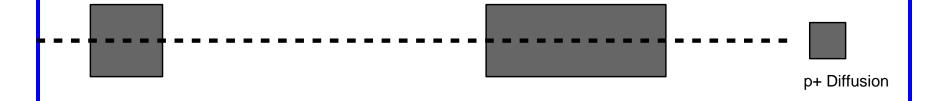


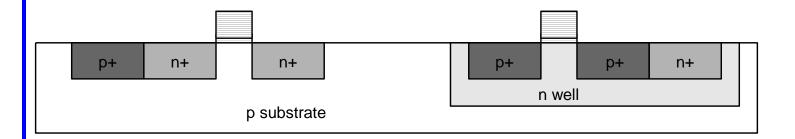
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#### **P-Diffusion**

□ Similar set of steps form p+ diffusion regions for pMOS source and drain and substrate contact





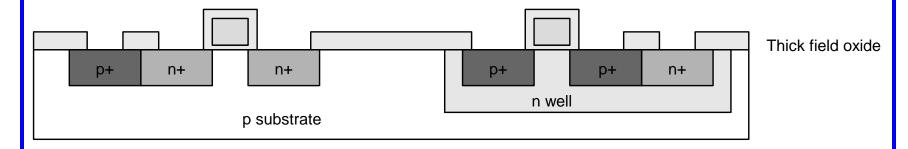
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#### Contacts

- Now we need to wire together the devices
- Cover chip with thick field oxide
- Etch oxide where contact cuts are needed





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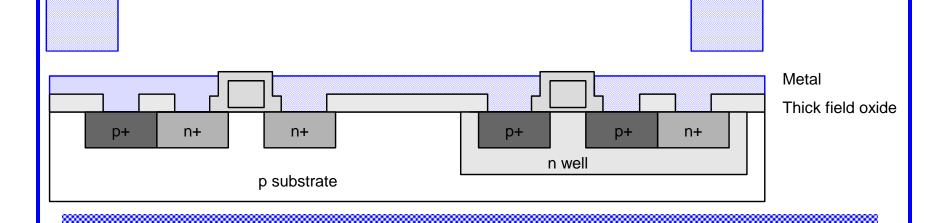
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#### Metalization

☐ Sputter on aluminum over whole wafer

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□ Pattern to remove excess metal, leaving wires



**CMOS VLSI Design** 

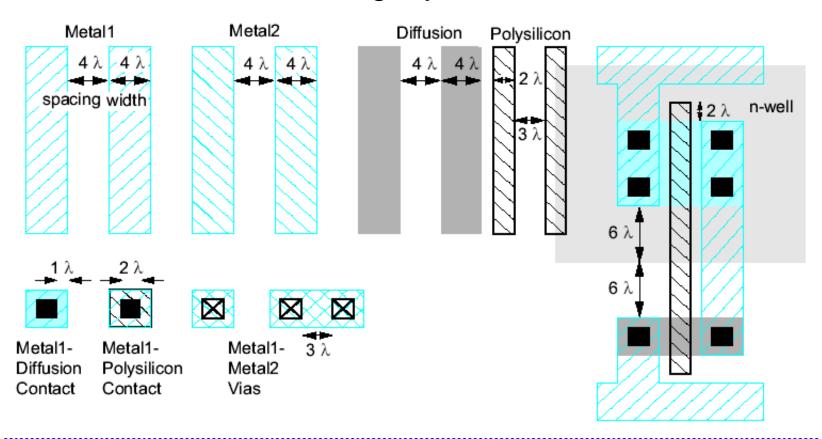
Metal

## Layout

- ☐ Chips are specified with set of masks
- Minimum dimensions of masks determine transistor size (and hence speed, cost, and power)
- $\Box$  Feature size f = distance between source and drain
  - Set by minimum width of polysilicon
- ☐ Feature size improves 30% every 3 years or so
- Normalize for feature size when describing design rules
- $\square$  Express rules in terms of  $\lambda = f/2$ 
  - E.g.  $\lambda$  = 0.3  $\mu$ m in 0.6  $\mu$ m process

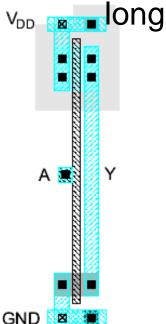
# Simplified Design Rules

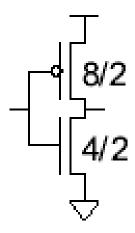
☐ Conservative rules to get you started

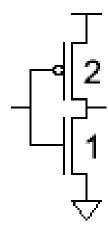


## **Inverter Layout**

- ☐ Transistor dimensions specified as Width / Length
  - Minimum size is  $4\lambda / 2\lambda$ , sometimes called 1 unit
  - In f = 0.6  $\mu$ m process, this is 1.2  $\mu$ m wide, 0.6  $\mu$ m







## Summary

- MOS Transistors are stack of gate, oxide, silicon
- Can be viewed as electrically controlled switches
- Build logic gates out of switches
- Draw masks to specify layout of transistors
- Now you know everything necessary to start designing schematics and layout for a simple chip!